

40V Step-Down Converter with ECO-MODE™ and LDO Regulator

Check for Samples: [TPS65320-Q1](#)

FEATURES

- Qualified for Automotive Applications
- AEC-Q100 Qualified with the Following Results:
 - Device Temperature Grade 1: –40°C to 125°C Ambient Operating Temperature
 - Device HBM ESD Classification Level H2
 - Device CDM ESD Classification Level C3B
- One High VIN Buck Converter
 - Input range of 3.6 V to 40 V
 - Asynchronous Buck Converter (int. FET)
 - Max Load Current 3.2 A, Output Adj. 1.1 V to 20 V
 - High Duty Cycle Operation Supported
 - Adjustable Switch Mode Frequency 100 kHz to 2.5 MHz
 - Less Than 140-μA Standby Current in Low Power Mode
- One Low Dropout Voltage (LDO) Regulator
 - 280-mA Current Capability with 40-μA Standby Current in Low Load Condition
 - Input Supply Auto Source to Balance Efficiency and Low Standby Current
 - Power Good Output (Push Pull)
 - Low Dropout Voltage of 300 mV at $I_{OUT} = 200\text{ mA}$ (Typ)
- Overcurrent Protection for all Regulators
- Overtemperature Protection
- 14-Pin HTSSOP Package with PowerPAD™

APPLICATIONS

- Qualified for Automotive Applications
- Infotainment, Telematics
- TFT Cluster
- Advanced Driver Assistant System

DESCRIPTION

The TPS65320-Q1 power supply is a combination of a single high voltage switch mode asynchronous buck power supply and an LDO regulator. This is a monolithic high voltage switching regulator with an integrated switch of 40 V, a power MOSFET, and a low standby current LDO. The device has a voltage supervisor which monitors the outputs of the switch mode power supply. To reduce heat, the input supply of the LDO can auto source from the input voltage to the output of the buck. The low voltage tracking feature can possibly eliminate the need to use a boost converter during cold crank conditions.

The TPS65320-Q1 has a switching frequency range from 100 kHz to 2.5 MHz, providing the customer with a flexible design to fit their system needs. The external loop compensations allow the user to optimize the converter response for the appropriate operating conditions. The standby current of the buck regulator is 140 μA for low power mode.

The device has built-in protection features such as soft start, pulse by pulse current limit, thermal sensing, and shutdown due to excessive power dissipation.



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APPLICATION SCHEMATIC

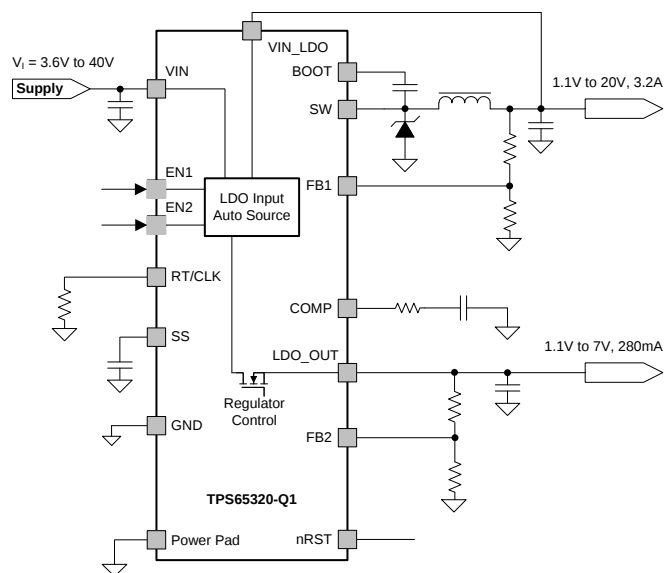


Figure 1. Typical Application Schematic

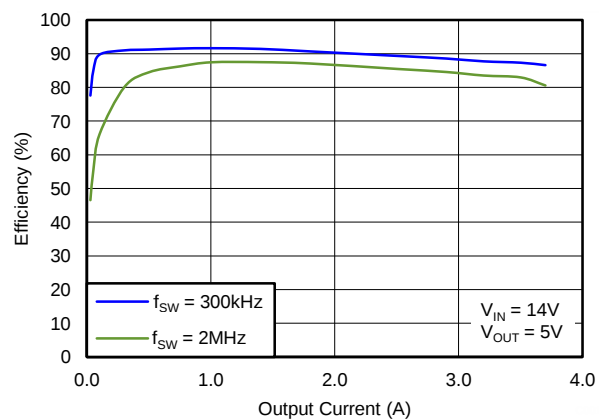


Figure 2. Buck Efficiency vs. Output Current



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

ORDERING INFORMATION⁽¹⁾

T _A	ORDERABLE PART NUMBER ⁽²⁾	TOP-SIDE MARKING
–40°C to 125°C	TPS65320QPWPRQ1	

- (1) For the most current package and ordering information see the Package Option Addendum at the end of this document, or see the TI website at www.ti.com.
- (2) Package drawings, thermal data, and symbolization are available at www.ti.com/packaging.

ABSOLUTE MAXIMUM RATINGS⁽¹⁾

over operating free-air temperature range (unless otherwise noted)

			VALUE	UNIT
Supply Inputs	VIN		−0.3 to 45	V
	VIN_LDO		−0.3 to 20	
Control	EN1, EN2		−0.3 to 45	V
Buck Converter	FB1		−0.3 to 3.6	V
	SW		−0.3 to 40 −2 V for 30 ns	
	BOOT		−0.3 to 46	
	BOOT-SW		8	
	COMP		−0.3 to 3.6	
	SS		−0.3 to 3.6	
	RT/CLK, SS		−0.3 to 3.6	
LDO Regulator	LDO_OUT		−0.3 to 7	V
	FB2		−0.3 to 7	
	nRST		−0.3 to 7	
Electrostatic Discharge (ESD) Ratings	Human body model (HBM) AEC-Q100 classification level H2		2	kV
	Charged device model (CBM) AEC-Q100 classification level C3B	Corner pins	750	V
		All other pins	500	
T _A	Operating ambient temperature		125	°C
T _{STG}	Storage temperature range		−55 to 165	°C
T _J	Operating junction temperature range		−40 to 150	°C

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

THERMAL INFORMATION

THERMAL METRIC ⁽¹⁾		TPS65320-Q1 PWP (14 PINS)	UNIT
θ _{JA}	Junction-to-ambient thermal resistance	49.9	°C/W
θ _{JCTop}	Junction-to-case (top) thermal resistance	31	
θ _{JB}	Junction-to-board thermal resistance	26.6	
ψ _{JT}	Junction-to-top characterization parameter	1	
ψ _{JB}	Junction-to-board characterization parameter	26.4	
θ _{JCbot}	Junction-to-case (bottom) thermal resistance	3.7	

- (1) For more information about traditional and new thermal metrics, see the *IC Package Thermal Metrics* application report, [SPRA953](http://www.ti.com/lit/an/spra953).

RECOMMENDED OPERATING CONDITIONS

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
Supply Inputs	V _{IN}	3.6		40	V
	V _{IN_LDO}	3.6		20	
Buck Regulator	BOOT1	3.6		46	V
	SW1	–1		40	
	VFB1	0		3	
	SS	0		3	
	COMP	0		3	
	RT/CLK	0		3	
LDO Regulator	LDO_OUT	1.1		5.5	V
	VFB2	0		5.25	
	nRST	0		5.25	
Control	EN1	0		40	V
	EN2	0		40	
Temperature	Operating junction temperature range, T _J	–40		150	°C

ELECTRICAL CHARACTERISTICS

V_{IN} = 6 V to 27 V, EN1 = EN2 = V_{IN}, T_J = –40°C to 150°C, unless otherwise noted

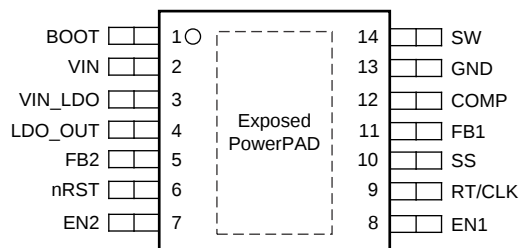
PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
VIN (INPUT POWER SUPPLY)						
Operating input voltage		Normal mode, after initial start-up	3.6	14	40	V
Shutdown supply current		EN1 = EN2 = 0 V, 25°C		2	5	μA
ENABLE AND UVLO (EN1 AND EN2 PIN)						
Enable low level					0.7	V
Enable high level			2.5			V
VIN falling	Internal UVLO threshold	Ramp VIN down until output is turned OFF	2	2.6	3	V
VIN rising	Internal UVLO threshold	Ramp VIN up until output is turned ON	2.5	2.8	3.2	V
BUCK CONVERTER						
Operating: non-switching supply		VFB1 = 0.83 V, VIN = 12 V, 25°C		110	140	μA
Output capacitor		ESR = 0.001 Ω to 0.1 Ω, large output capacitance may be required for load transient	10			μF
HIGH-SIDE MOSFET						
On-resistance		VIN = 12 V, SW = 6 V		127	250	mΩ
tON-min	Minimum on-time	fSW = 2.5 MHz		100		ns
ERROR AMPLIFIER						
Input current				50		nA
Error amplifier transconductance (gM)		−2 μA < ICOMP < 2 μA, VCOMP = 1 V		310		μS
Error amplifier transconductance (gM) during soft start		−2 μA < ICOMP < 2 μA, VCOMP = 1 V VFB1 = 0.4 V		70		μS
Error amplifier DC gain		VFB1 = 0.8 V		100		dB
Error amplifier bandwidth				6000		kHz
Error amplifier source/sink		VCOMP = 1 V, 100-mV overdrive		±27		μA
COMP to switch current transconductance				10.5		A/V
VFB1	Voltage reference	VVIN_LDO = 3.6 V to 10 V	0.788	0.8	0.812	V
CURRENT LIMIT						
Current limit threshold		VIN = 12 V, TJ = 25°C	4	6		A

ELECTRICAL CHARACTERISTICS (continued)
 $V_{IN} = 6\text{ V to } 27\text{ V}$, $EN1 = EN2 = V_{IN}$, $T_J = -40^{\circ}\text{C to } 150^{\circ}\text{C}$, unless otherwise noted

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
TIMING RESISTOR AND EXTERNAL CLOCK (RT/CLK PIN)						
f_{SW}	Switching frequency range using RT mode		100		2500	kHz
	Switching frequency	RT = 200 k Ω	450	581	720	kHz
	Switching frequency range using CLK mode		300		2200	kHz
	Minimum CLK input pulse width			40		ns
RT/CLK	High threshold			1.9	2.2	V
	Low threshold		0.5	0.7		V
	Falling edge to SW rising edge delay	Measured at 500 kHz with RT resistor in series		60		ns
PLL	Lock in time	Measured at 500 kHz		100		μ s
LDO						
$\Delta V_{LINE-REG}$	Line regulation	$V_{IN} = 6\text{ V to } 30\text{ V}$, $I_{OUT} = 10\text{ mA}$, $V_{OUT} = 3.3\text{ V}$			20	mV
$\Delta V_{LOAD-REG}$	Load regulation	$I_{OUT} = 10\text{ mA to } 200\text{ mA}$, $V_{IN} = 14\text{ V}$, $V_{OUT} = 3.3\text{ V}$			35	mV
$V_{DROPOUT}$ ($V_{IN} - V_{OUT}$)	Dropout voltage	$I_{OUT} = 200\text{ mA}$		300	450	mV
I_{OUT}	Output current	V_{OUT} in regulation	0		280	mA
	Error amplifier DC gain			800		V/V
VIN_LDO	Operating input voltage on VIN_LDO pin	The input of the LDO in certain conditions	4		20	V
V_{FB2}	Voltage reference	$V_{LDO_OUT} = 1\text{ V to } 5\text{ V}$	0.788	0.8	0.812	V
I_{CL}	Output current limit	$V_{OUT} = 0\text{ V}$ (V_{OUT} pin is shorted to ground)	280		1000	mA
$I_{q_LPM_}$	Quiescent current	EN1 = 0 V, EN2 = 5 V, $I_{OUT} = 0.01\text{ mA to } 0.75\text{ mA}$		28	40	μ A
PSRR	Power supply ripple rejection	$V_{IN-RIPPLE} = 0.5\text{ V}_{PP}$, $I_{OUT} = 200\text{ mA}$, frequency = 100 Hz, $V_{OUT} = 5\text{ V}$ and $V_{OUT} = 3.3\text{ V}$		60		dB
		$V_{IN-RIPPLE} = 0.5\text{ V}_{PP}$, $I_{OUT} = 200\text{ mA}$, frequency = 150 kHz, $V_{OUT} = 5\text{ V}$ and $V_{OUT} = 3.3\text{ V}$		30		
	Output capacitor	ESR = 0.001 Ω to 100 m Ω , large output capacitance may be required for load transient	1		40	μ F
RESET (nRST PIN)						
	RESET threshold	LDO_OUT decreasing	88	92	95	%
V_{OH}	Output high		$-5\% \times V_{Ido_out}$			V
V_{OL}	Output low	Reset asserted due to falling LDO_OUT, $I_{OL} = 1\text{ mA}$	0	0.045	0.4	V
	Filter time	Delay before nRST is asserted low	6	10	15	μ s
SS (INTERNAL SOFT START TIMER FOR SWITCH MODE CONVERTER)						
I_{SS}	Soft start source current	SS = 0 V		2	4	μ A
$T_{SHUTDOWN}$	Thermal shutdown trip point			170		$^{\circ}\text{C}$
T_{hys}	Hysteresis			10		$^{\circ}\text{C}$

PIN CONFIGURATION

TPS65320-Q1
PWP-14 HTSSOP Package
(Top View)



PIN FUNCTIONS

PIN		I/O	DESCRIPTION
NAME	NO.		
BOOT	1	O	Boot node for LX
VIN	2	I	Input for internal supply and drain node input for internal high-side MOSFET
VIN_LDO	3	I	The output of the buck is chosen as LDO input when buck and LDO are both ON
LDO_OUT	4	O	Linear regulator output
FB2	5	I	Remote sense input for LDO regulator, a resistor network connection between this pin and ground and this pin and LDO_OUT
nRST	6	O	Active low, push-pull reset output, asserted high (at the actual LDO output voltage) after the LDO of the device starts regulating
EN2	7	I	Enable and disable input for LDO (high voltage tolerant) internally pulls to ground. Must be externally pulled up to enable.
EN1	8	I	Enable and disable input for buck converter (high voltage tolerant) internally pulls to ground. Must be externally pulled up to enable.
RT/CLK	9	I	External resistor connected ground to program the internal oscillator. An alternative option is to feed an external clock to provide a reference for the switching frequency.
SS	10	I	External capacitor to ground to set the soft start time
FB1	11	I	Remote sense input for buck converter, a resistor network connection between this pin and ground and this pin and buck converter output
COMP	12	O	Buck error amplifier output to connect external compensation components
GND	13	O	Ground
SW	14	I	Source node of internal switching FET
Exposed PowerPAD™			Electrically connect to ground and solder to ground plane of PCB for thermal efficiency

TYPICAL CHARACTERISTICS

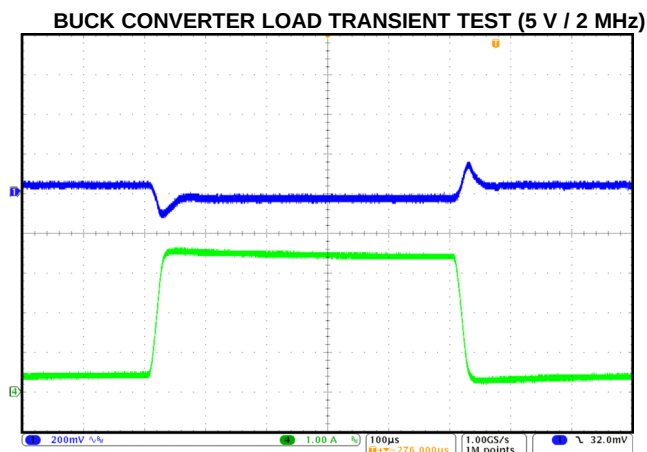


Figure 3.

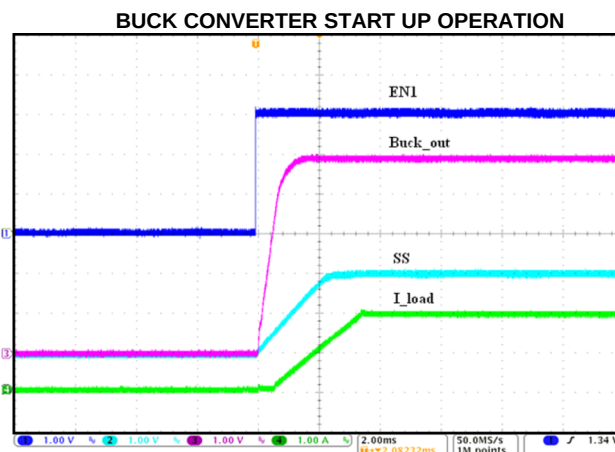


Figure 4.

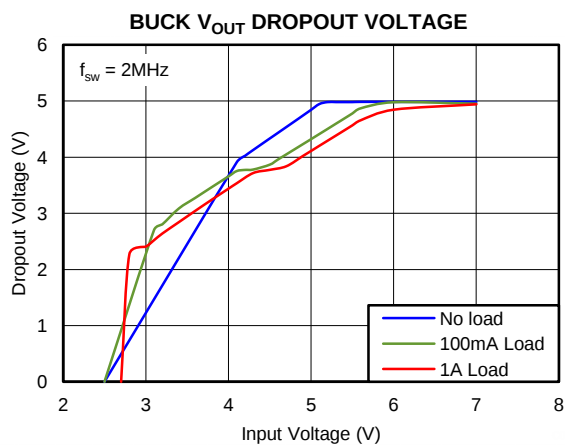


Figure 5.

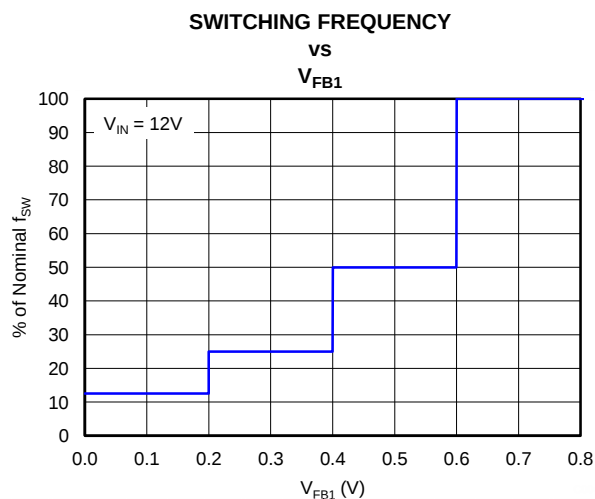


Figure 6.

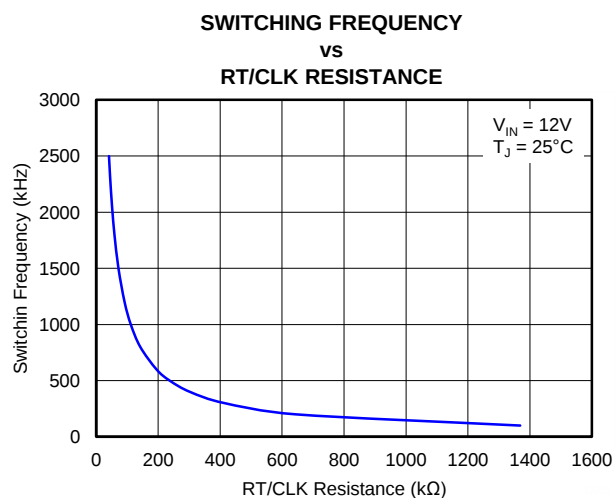


Figure 7.

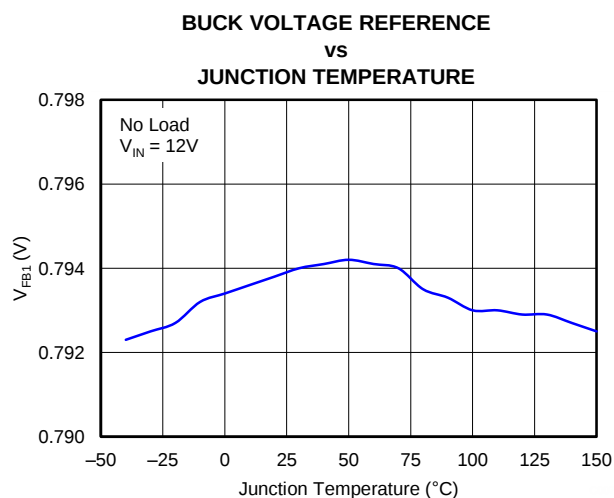


Figure 8.

TYPICAL CHARACTERISTICS (continued)

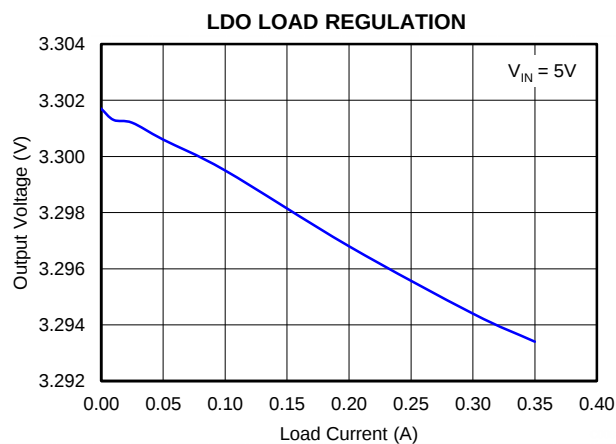


Figure 9.

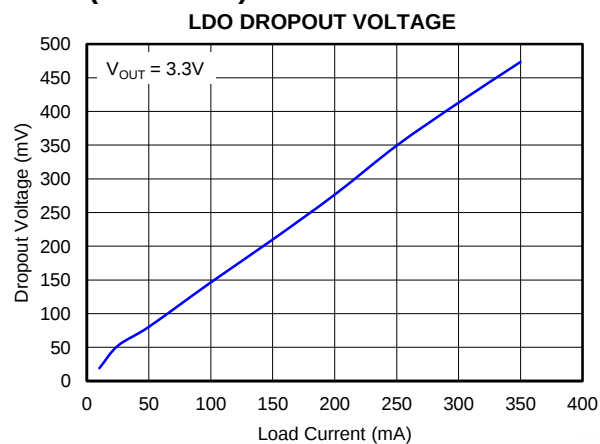


Figure 10.

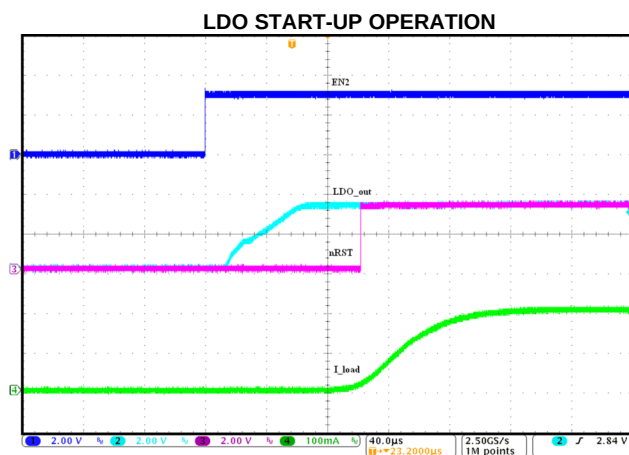


Figure 11.

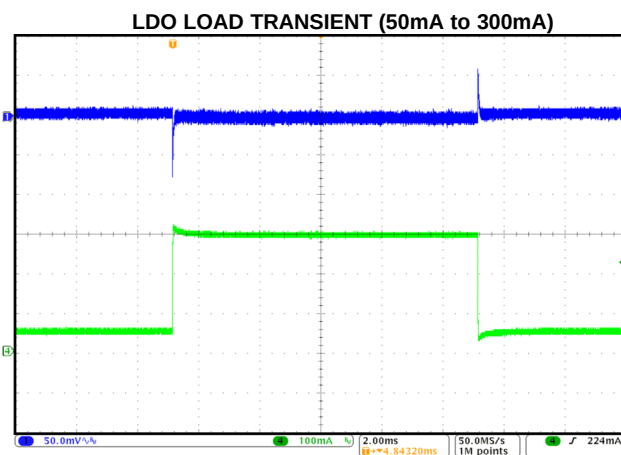


Figure 12.

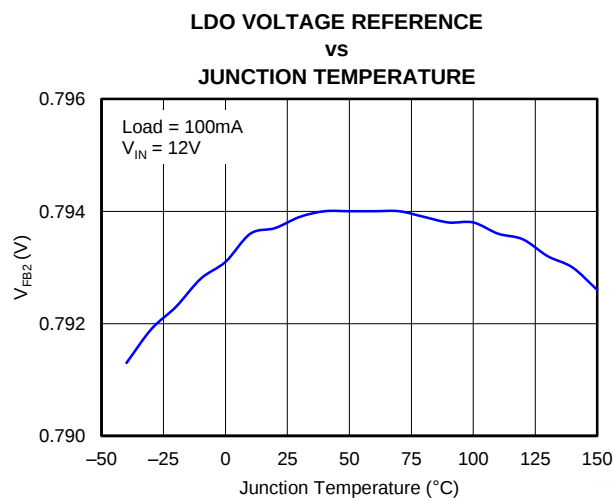


Figure 13.

INTERNAL FUNCTIONAL BLOCKS

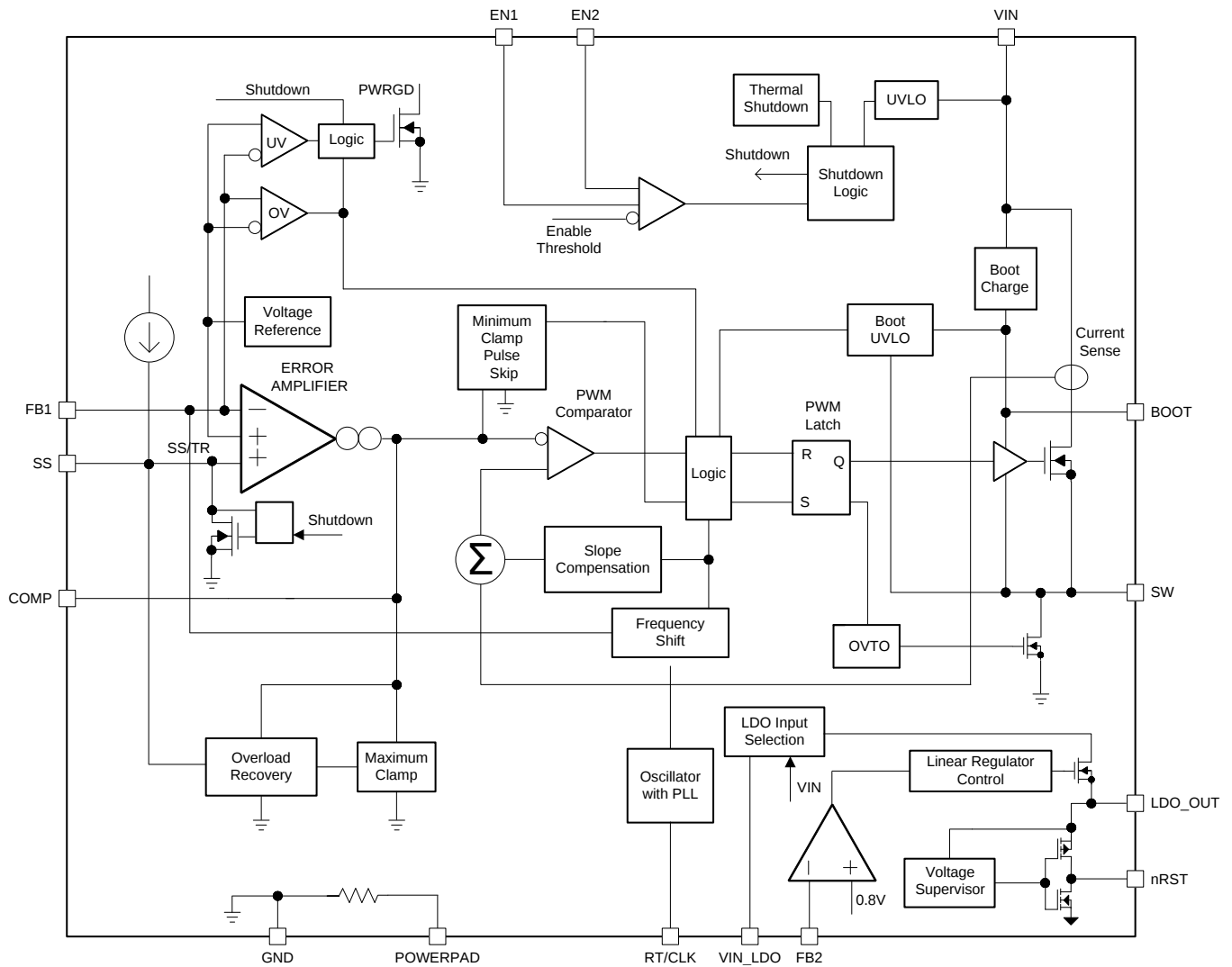


Figure 14. Functional Block Diagram

DETAILED DESCRIPTION

The TPS65320-Q1 device is a 40-V, 3.2-A, step-down (buck) converter with a 280-mA LDO linear regulator. These two regulators both have low quiescent consumption during the light load to prolong the battery life.

The buck converter improves performance during line and load transients by implementing a constant frequency and current mode control which reduces output capacitance, and simplifying external frequency compensation design. The wide switching frequency of 100 kHz to 2500 kHz allows for efficiency and size optimization when selecting the output filter components. The switching frequency can be adjusted by using a resistor to ground on the RT/CLK pin. The buck converter has an internal phase-locked loop (PLL) on the RT/CLK pin that is used to synchronize the power switch turn on to a falling edge of an external system clock.

The TPS65320-Q1 reduces the external component count by integrating the boot recharge diode. The bias voltage for the integrated high-side MOSFET is supplied by a capacitor on the BOOT to SW pin. The boot capacitor voltage is monitored by an undervoltage lock out (UVLO) circuit and will turn the high-side MOSFET off when the boot voltage falls below a preset threshold. The TPS65320-Q1 can operate at high duty cycles because of the boot UVLO. The output voltage can be stepped down to as low as the 0.8-V reference. Soft start is featured to minimize inrush currents or to provide power supply sequencing during power up. A small value capacitor should be coupled to the pin to adjust the soft start time. A resistor divider can be coupled to the pin for critical power supply sequencing requirements.

The LDO regulator only consumes about 40- μ A current in light load. The LDO can also track battery when battery voltage is low (in cold crank condition). The input of the LDO has a unique feature; it can auto source the input supply from either the buck output or the battery. If both the buck and LDO are enabled, the input of the LDO is switched to the output of the buck to reduce heat. When the buck is disabled or the buck output voltage is out of regulation (V_{FB1} less than 91% of V_{REF}), the LDO input is switched to the input voltage automatically.

The LDO of the TPS65320-Q1 device has a power good comparator (nRST) that asserts when the regulated output voltage is less than 91% of the nominal output voltage.

Buck Converter

Fixed Frequency PWM Control

The TPS65320-Q1 uses an adjustable, fixed-frequency peak current mode control. The output voltage is compared through external resistors on the VFB1 pin to an internal voltage reference through an error amplifier that drives the COMP pin. An internal oscillator initiates the turn on of the high-side power switch. The error amplifier output is compared to the high-side power switch current. When the power switch current reaches the level set by the COMP voltage, the power switch is turned off. The COMP pin voltage increases and decreases as the output current increases and decreases. The device implements a current limit by clamping the COMP pin voltage to a maximum level.

Slope Compensation Output

The TPS65320-Q1 adds a compensating ramp to the switch current signal. This slope compensation prevents sub-harmonic oscillations. The available peak inductor current remains constant over the full duty cycle range.

Pulse Skip Eco-Mode™

The TPS65320-Q1 operates in a pulse skip Eco-mode at light load currents to improve efficiency by reducing switching and gate drive losses. The TPS65320-Q1 is designed so that if the output voltage is within regulation and the peak switch current at the end of any switching cycle is below the pulse skipping current threshold, the device enters Eco-mode. The power supply enters Eco-mode when the output current is lower than 5 mA. This current threshold is the current level corresponding to a nominal COMP voltage, or 720 mV.

When in Eco-mode, the COMP pin voltage is clamped at 720 mV and the high-side MOSFET is inhibited. Further decreases in load current or in output voltage cannot drive the COMP pin below this clamp voltage level.

Since the device is not switching, the output voltage begins to decay. As the voltage control loop compensates for the falling output voltage, the COMP pin voltage begins to rise. At this time, the high-side MOSFET is enabled and a switching pulse initiates on the next switching cycle. The peak current is set by the COMP pin voltage. The output voltage recharges the regulated value, then the peak switch current starts to decrease, and eventually falls below the Eco-mode threshold, at which time the device enters Eco-mode again.

For Eco-mode operation, the TPS65320-Q1 senses peak current, not average or load current. Therefore, the load current where the device enters Eco-mode is dependent on the output inductor value. When the load current is low and the output voltage is within regulation, the device enters a sleep mode and draws only 140-μA input quiescent current. The internal PLL remains operating when the device is in sleep mode.

Low Dropout Operation and Bootstrap Voltage (BOOT)

The TPS65320-Q1 has an integrated boot regulator and requires a small ceramic capacitor between the BOOT and SW pins to provide the gate-drive voltage for the high-side MOSFET. The BOOT capacitor is refreshed when the high-side MOSFET is off and the low-side diode conducts. The value of this ceramic capacitor should be 0.1 μF. A ceramic capacitor with an X7R or X5R grade dielectric with a voltage rating of 10 V or higher is recommended because of the stable characteristics over temperature and voltage.

To improve drop out, the TPS65320-Q1 is designed to operate at 100% duty cycle as long as the BOOT to SW pin voltage is greater than 2.1 V. When the voltage from BOOT to SW drops below 2.1 V, the high-side MOSFET is turned off using a UVLO circuit which allows the low-side diode to conduct and refresh the charge on the BOOT capacitor. Since the supply current sourced from the BOOT capacitor is low, the high-side MOSFET can remain on for more switching cycles than are required to refresh the capacitor, and therefore the effective duty cycle of the switching regulator is high.

The effective duty cycle during dropout of the regulator is mainly influenced by the voltage drops across the power MOSFET, inductor resistance, low-side diode, and printed circuit board resistance. During operating conditions in which the input voltage drops and the regulator is operating in continuous conduction mode, the high-side MOSFET can remain on for 100% of the duty cycle to maintain output regulation until the BOOT to SW voltage falls below 2.1 V.

Attention must be taken in maximum duty cycle applications which experience extended time periods with light loads or no load. When the voltage across the BOOT capacitor falls below the 2.1-V UVLO threshold, the high-side MOSFET is turned off, but there may not be enough inductor current to pull the SW pin down to recharge the BOOT capacitor. The high-side MOSFET of the regulator stops switching because the voltage across the BOOT capacitor is less than 2.1 V. The output capacitor then decays until the difference in the input voltage and output voltage is greater than 2.1 V, at which point the BOOT UVLO threshold is exceeded, and the device starts switching again until the desired output voltage is reached. This operating condition persists until the input voltage and/or the load current increases. When TPS65320-Q1 tries to turn on the high-side MOSFET continuously during the high-side off state, the internal small low-side MOSFET is turned on for a short time to charge the BOOT capacitor. Then the SW node pulls low to recharge the BOOT capacitor for maximum duty cycle operation.

Error Amplifier

The buck converter of the TPS65320-Q1 has a transconductance amplifier for the error amplifier. The error amplifier compares the VFB1 voltage to the lower of the internal soft-start (SS) voltage or the internal 0.8-V voltage reference. The transconductance (gm) of the error amplifier is 310 μA/V during normal operation. During the soft-start operation, the transconductance is a fraction of the normal operating gm. When the voltage of the VFB1 pin is below 0.8 V and the device is regulating using internal SS voltage, the gm is 70 μA/V. The frequency compensation components (capacitor, series resistor, and capacitor) are added to the COMP pin to ground.

Voltage Reference

The voltage reference system produces a precise ±2% voltage reference over temperature by scaling the output of a temperature stable band-gap circuit.

Slow Start/Tracking Pin (SS/TR)

The TPS65320-Q1 effectively uses the lower voltage of the internal voltage reference or the SS/TR pin voltage as the reference voltage of the power supply and regulates the output accordingly. A capacitor on the SS/TR pin to ground implements a slow start time. The TPS65320-Q1 has an internal pullup current source of 2 μA that charges the external slow start capacitor. The calculations for the slow start time (10% to 90%) are shown in [Equation 1](#). The voltage reference (V_{REF}) is 0.8 V and the slow start current (I_{SS}) is 2 μA. The slow start capacitor should remain lower than 0.47 μF and greater than 0.47 nF.

$$C_{ss}(\text{nF}) = \frac{T_{ss}(\text{ms}) \times I_{ss}(\mu\text{A})}{V_{ref}(\text{V}) \times 0.8} \quad (1)$$

At power up, the TPS65320-Q1 does not start switching until the slow start pin is discharged to less than 40 mV to ensure a proper power up.

Also during normal operation the TPS65320-Q1 stops switching and the SS/TR must be discharged to 40 mV when the V_{IN} UVLO is exceeded, the EN pin is pulled below the enable threshold, or if a thermal shutdown event occurs.

Overload Recovery Circuit

The TPS65320-Q1 has an overload recovery (OLR) circuit. The OLR circuit slow starts the output from the overload voltage to the nominal regulation voltage when the fault condition is removed. The OLR circuit discharges the SS/TR pin to a voltage slightly greater than the VFB1 pin voltage using an internal pulldown of 382 μ A when the error amplifier is changed to a high voltage from a fault condition. When the fault condition is removed, the output slow starts from the fault voltage to nominal output voltage.

Constant Switching Frequency and Timing Resistor (RT/CLK Pin)

The switching frequency of the TPS65320-Q1 is adjustable over a wide range from approximately 100 kHz to 2500 kHz by placing a resistor on the RT/CLK pin. The RT/CLK pin voltage is typically 0.5 V and must have a resistor to ground to set the switching frequency. To determine the timing resistance for a given switching frequency, use [Equation 2](#) or the curves in [Figure 6](#). To reduce the solution size, the user typically sets the switching frequency as high as possible, but tradeoffs of the supply efficiency, maximum input voltage, and minimum controllable on-time should be considered. The minimum controllable on-time is typically 100 ns and limits the maximum operating input voltage. The maximum switching frequency is also limited by the frequency shift circuit. More details of the maximum switching frequency are discussed in the following sections.

$$R_T(k\Omega) = \frac{206033}{f_{sw}(kHz)^{1.0888}} \quad (2)$$

Overcurrent Protection and Frequency Shift

The TPS65320-Q1 implements current mode control which uses the COMP pin voltage to turn off the high-side MOSFET on a cycle by cycle basis. Each cycle the switch current and COMP pin voltage are compared. When the peak switch current intersects the COMP voltage, the high-side switch is turned off. During overcurrent conditions that pull the output voltage low, the error amplifier will respond by driving the COMP pin high, increasing the switch current. The error amplifier output is clamped internally, which functions as a switch current limit.

The TPS65320-Q1 implements a frequency shift. The switching frequency is divided by 8, 4, 2, and 1 as the voltage ramps from 0 to 0.8 volts on the VFB1 pin. During short-circuit events (particularly with high-input voltage applications), the control loop has a finite minimum controllable on-time and the output has a low voltage. During the switch-on time, the inductor current ramps to the peak current limit because of the high-input voltage and minimum on-time. During the switch off time, the inductor would normally not have enough off time and output voltage for the inductor to ramp down by the ramp up amount. The frequency shift effectively increases the off time allowing the current to ramp down.

Selecting the Switching Frequency

The switching frequency that is selected should be the lower value of the two equations, [Equation 3](#) and [Equation 4](#). [Equation 3](#) is the maximum switching frequency limitation set by the minimum controllable on-time. Setting the switching frequency above this value causes the regulator to skip switching pulses.

[Equation 4](#) is the maximum switching frequency limit set by the frequency shift protection. To have adequate output short-circuit protection at high-input voltages, the switching frequency should be set to be less than the $f_{sw}(\text{maxshift})$ frequency. In [Equation 4](#), to calculate the maximum switching frequency one must take into account that the output voltage decreases from the nominal voltage to 0 volts, and the f_{div} integer increases from 1 to 8 corresponding to the frequency shift.

In [Figure 15](#), the solid line illustrates a typical safe operating area regarding frequency shift and assumes the output voltage is zero volts, the resistance of the inductor is 0.130 Ω , the FET on resistance is 0.127 Ω , and the diode voltage drop is 0.5 V. The dashed line is the maximum switching frequency to avoid pulse skipping.

$$f_{SW}(\text{max skip}) = \left(\frac{1}{t_{ON}} \right) \times \left(\frac{(I_L \times R_{dc} + V_{out} + V_d)}{(V_{in} - I_L \times R_{hs} + V_d)} \right) \quad (3)$$

$$f_{SW}(\text{shift}) = \left(\frac{f_{div}}{t_{ON}} \right) \times \left(\frac{(I_L \times R_{dc} + V_{outsc} + V_d)}{(V_{in} - I_L \times R_{hs} + V_d)} \right) \quad (4)$$

Where:

I_L = inductor current

R_{DC} = inductor resistance

V_{IN} = maximum input voltage

V_{OUT} = output voltage

V_{OUTSC} = output voltage during short

V_d = diode voltage drop

R_{hs} = FET on resistance (typ. 127 mΩ)

t_{ON} = controllable on-time (typ. 100 ns)

f_{div} = frequency divide factor (equals 1, 2, 4 or 8)

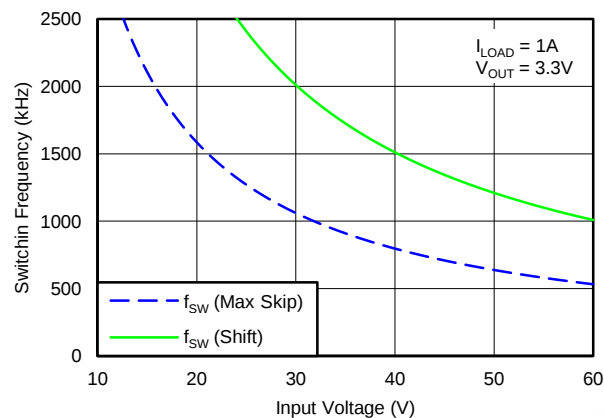


Figure 15. Maximum Switching Frequency vs. Input Voltage

How to Interface to RT/CLK Pin

The RT/CLK pin can be used to synchronize the regulator to an external system clock. To implement the synchronization feature connect a square wave to the RT/CLK pin through the circuit network shown in [Figure 16](#). The square wave amplitude must transition lower than 0.5 V and higher than 2.2 V on the RT/CLK pin and have an on-time greater than 40 ns and an off time greater than 40 ns. The synchronization frequency range is 300 kHz to 2200 kHz. The rising edge of the SW is synchronized to the falling edge of RT/CLK pin signal. The external synchronization circuit should be designed in such a way that the device has the default frequency set resistor connected from the RT/CLK pin to ground should the synchronization signal turn off. It is recommended to use a frequency set resistor connected as shown in [Figure 16](#) through a 50-Ω resistor to ground. The resistor should set the switching frequency close to the external CLK frequency. It is recommended to AC couple the synchronization signal through a 10-pF ceramic capacitor to RT/CLK pin and a 4-kΩ series resistor. The series resistor reduces SW jitter in heavy load applications when synchronizing to an external clock and in applications which transition from synchronizing to RT mode. The first time the CLK is pulled above the CLK threshold the device switches from the RT resistor frequency to PLL mode. The internal 0.5-V voltage source is removed and the CLK pin becomes high impedance as the PLL starts to lock onto the external signal. Since there is a PLL on the regulator, the switching frequency can be higher or lower than the frequency set with the external resistor. The device transitions from the resistor mode to the PLL mode and then increases or decreases the switching frequency until the PLL locks onto the CLK frequency within 100 microseconds.

When the device transitions from the PLL to resistor mode, the switching frequency slows down from the CLK frequency to 150 kHz, then reapplies the 0.5-V voltage, and the resistor then sets the switching frequency. The switching frequency is divided by 8, 4, 2, and 1 as the voltage ramps from 0 to 0.8 volts on FB1 pin. The device implements a digital frequency shift to enable synchronizing to an external clock during normal startup and fault conditions.

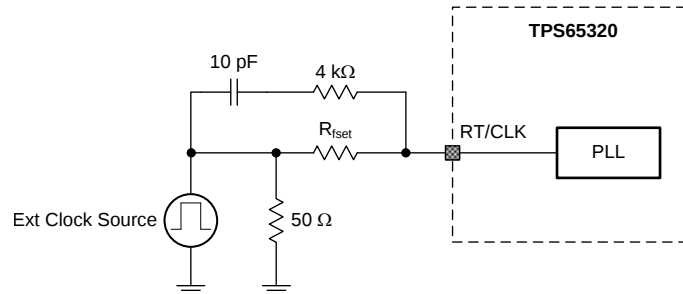


Figure 16. Synchronizing to a System Clock

Enable and Undervoltage Lockout

TPS65320-Q1 enable are high voltage tolerant input pins with an internal pull down circuit. A high input activates the devices and turns the regulators ON.

TPS65320-Q1 has an internal UVLO circuit to shutdown the output if the input voltage falls below an internally fixed UVLO threshold level. This ensures that both regulators are not latched into an unknown state during low-input voltage conditions. The regulators power up when the input voltage exceeds the voltage level.

Overvoltage Transient Protection

The TPS65320-Q1 incorporates an overvoltage transient protection (OVTP) circuit to minimize voltage overshoot when recovering from output fault conditions or strong unload transients on power supply designs with low value output capacitance. For example, when the power supply output is overloaded, the error amplifier compares the actual output voltage to the internal reference voltage. If the FB1 pin voltage is lower than the internal reference voltage for a considerable time, the output of the error amplifier responds by clamping the error amplifier output to a high voltage, thus requesting the maximum output current. Once the condition is removed, the regulator output rises and the error amplifier output transitions to the steady state duty cycle. In some applications, the power supply output voltage can respond faster than the error amplifier output can respond, this actuality leads to the possibility of an output overshoot. The OVTP feature minimizes the output overshoot when using a low value output capacitor by implementing a circuit to compare the FB1 pin voltage to the OVTP threshold (which is 109% of the internal voltage reference). If the FB1 pin voltage is greater than the OVTP threshold, the high-side MOSFET is disabled preventing current from flowing to the output and minimizing output overshoot. When the FB1 voltage drops lower than the OVTP threshold, the high-side MOSFET is allowed to turn on at the next clock cycle.

Small Signal Model for Loop Response

Figure 17 shows an equivalent model for the TPS65320-Q1 control loop which can be modeled in a circuit simulation program to check frequency response and dynamic load response. The error amplifier is a transconductance amplifier with a $g_{m_{ea}}$ of 310 $\mu A/V$. The error amplifier can be modeled using an ideal voltage controlled current source. The resistor R_o and capacitor C_o model the open loop gain and frequency response of the amplifier. The 1-mV AC voltage source between nodes a and b effectively breaks the control loop for the frequency response measurements. Plotting c/a shows the small signal response of the frequency compensation. Plotting a/b shows the small signal response of the overall loop. The dynamic loop response can be checked by replacing R_L with a current source that has the appropriate load step amplitude and step rate in a time domain analysis. This equivalent model is only valid for continuous conduction mode designs.

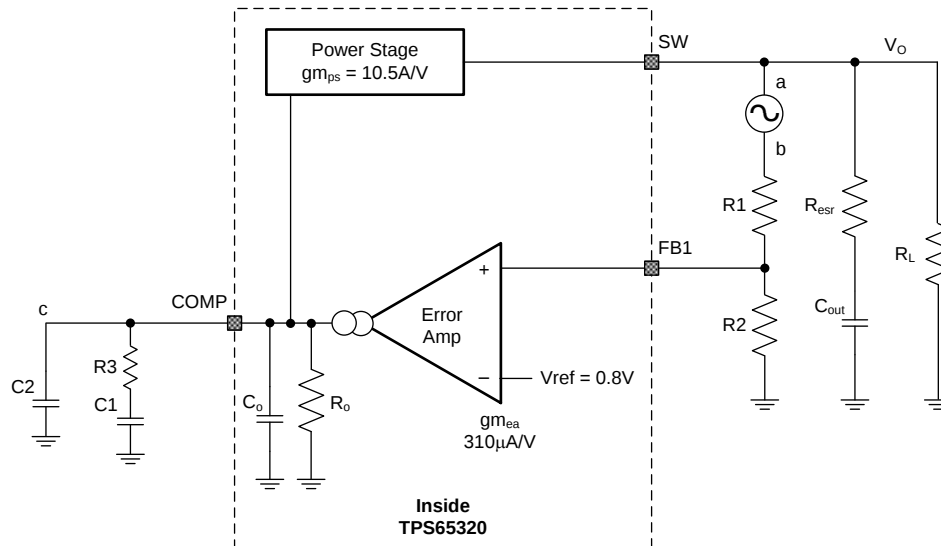


Figure 17. Small Signal Model for Loop Response

Simple Small Signal Model for Peak Current Mode Control

Figure 18 describes a simple small signal model that can be used to understand how to design the frequency compensation. The TPS65320-Q1 power stage can be approximated to a voltage-controlled current source (duty cycle modulator) supplying current to the output capacitor and load resistor. The control to output transfer function is shown in Equation 5 and consists of a DC gain, one dominant pole, and one ESR zero. The quotient of the change in switch current and the change in COMP pin voltage (node c in Figure 17) is the power stage transconductance. The $g_{m_{PS}}$ for the TPS65320-Q1 is 10.5 A/V. The low frequency gain of the power stage frequency response is the product of the transconductance and the load resistance as shown in Equation 6.

As the load current increases and decreases, the low frequency gain decreases and increases, respectively. This variation with the load may seem problematic at first, but the dominant pole moves with the load current (see Equation 7). The combined effect is highlighted by the dashed line in the right half of Figure 18. As the load current decreases, the gain increases and the pole frequency lowers, keeping the 0-dB crossover frequency the same for the varying load conditions, which makes it easier to design the frequency compensation. The type of output capacitor chosen determines whether the ESR zero has a profound effect on the frequency compensation design. Using high ESR aluminium electrolytic capacitors may reduce the number frequency compensation components needed to stabilize the overall loop because the phase margin increases from the ESR zero at the lower frequencies (see Equation 8).

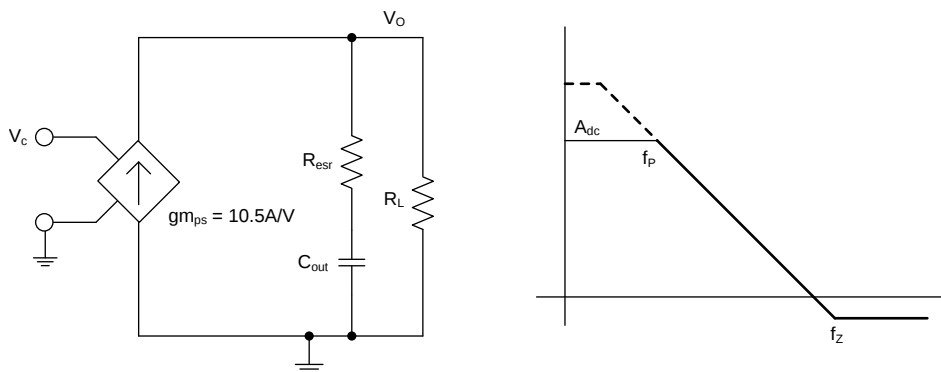


Figure 18. Simple Small Signal Model and Frequency Response for Peak Current Mode

$$\frac{V_{out}}{V_C} = A_{dc} \times \frac{\left(1 + \frac{s}{2\pi \times f_Z}\right)}{\left(1 + \frac{s}{2\pi \times f_P}\right)} \quad (5)$$

$$A_{dc} = g_{m_{ps}} \times R_L \quad (6)$$

$$f_{P_mod} = \frac{1}{2\pi \times R_L \times C_{out}} \quad (7)$$

$$f_{Z_mod} = \frac{1}{2\pi \times R_{ESR} \times C_{out}} \quad (8)$$

Small Signal Model for Frequency Compensation

The buck converter of the TPS65320-Q1 device uses a transconductance amplifier for the error amplifier. Compensation circuits are shown in [Figure 19](#). Type 2 circuits are most likely implemented in high bandwidth power-supply designs. The purpose of loop compensation is to ensure stable operation while maximizing dynamic performance. The Type 1 circuit is used with power-supply designs that have high-ESR aluminum electrolytic or tantalum capacitors. [Equation 9](#) and [Equation 10](#) show how to relate the frequency response of the amplifier to the small signal model in [Figure 19](#). The open-loop gain and bandwidth are modeled using the R_o and C_o shown in [Figure 19](#). See the [Application Information](#) section for a design example with a Type 2A network that has a low ESR output capacitor. For stability purposes, the target is to have a loop gain slope that is -20 dB / decade at the crossover frequency. Also, the crossover frequency should not exceed one-fifth of the switching frequency (120 kHz in the case of a 600-kHz switching frequency).

For dynamic purposes, the higher the bandwidth, the faster the load transient response. A large DC gain means high DC regulation accuracy (DC voltage changes little with load or line variations). To achieve this loop gain, the compensation components should be set according to the shape of the control-output node plot.

[Equation 9](#) through [Equation 19](#) are provided as a reference for users who prefer to compensate using the preferred methods. R_o and C_1 form the dominant pole (P1). A resistor (R_3) and a capacitor (C_1) in series to ground work as zero (Z1). In addition, a lower value capacitor (C_2) can be added in parallel with R_3 to work as an optional pole. It can be used to filter noise at switching frequency, and it is also needed if the output capacitor has high ESR.

If the prescribed method is preferred, use the method outlined in the [Application Information](#) section.

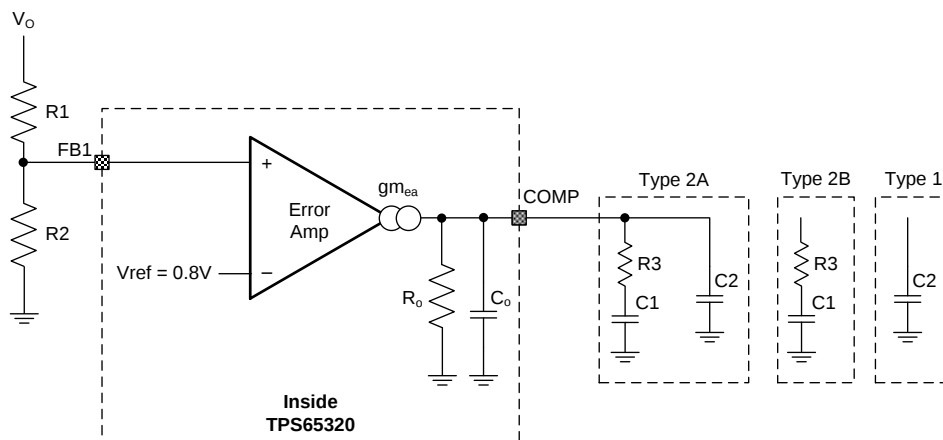


Figure 19. Types of Frequency Compensation

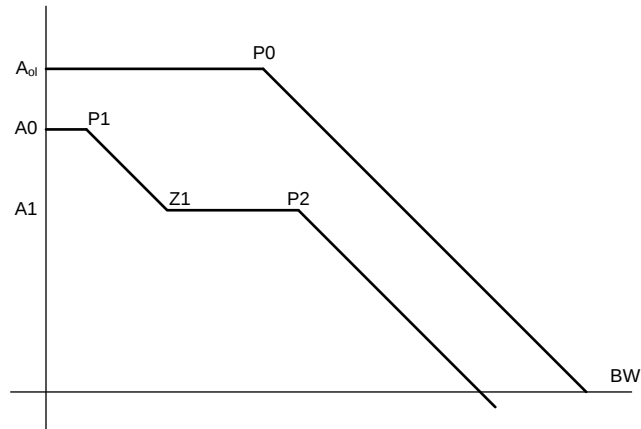


Figure 20. Frequency Response of the Type 2 Frequency Compensation

$$R_o = \frac{A_{ol} (V/V)}{g_{m_{ea}}} \quad (9)$$

$$C_o = \frac{g_{m_{ea}}}{2\pi \times BW(Hz)} \quad (10)$$

$$P0 = \frac{1}{2\pi \times R_o \times C0} \quad (11)$$

$$EA = A0 \times \frac{\left(1 + \frac{2}{2\pi \times f_{Z1}}\right)}{\left(1 + \frac{2}{2\pi \times f_{P1}}\right) \times \left(1 + \frac{2}{2\pi \times f_{P2}}\right)} \quad (12)$$

$$A0 = g_{m_{ea}} \times R_o \times \frac{R2}{R1 + R2} \quad (13)$$

$$A1 = g_{m_{ea}} \times R_o \parallel R3 \times \frac{R2}{R1 + R2} \quad (14)$$

$$P1 = \frac{1}{2\pi \times R_o \times C1} \quad (15)$$

$$Z1 = \frac{1}{2\pi \times R3 \times C1} \quad (16)$$

$$P2 = \frac{1}{2\pi \times R3 \times C2} \quad \text{Type 2A} \quad (17)$$

$$P2 = \frac{1}{2\pi \times R3 \times C_o} \quad \text{Type 2B} \quad (18)$$

$$P2 = \frac{1}{2\pi \times R_o \times C2} \quad \text{Type 1} \quad (19)$$

LDO Regulator

For the TPS65320-Q1 device, the internal linear regulator is designed for low power consumption and quiescent current about 40 μA in light load applications.

Charge Pump Operation

The LDO has an internal charge pump which turns on or off depending on the input voltage. The charge pump switching circuitry does not cause conducted emissions to exceed required thresholds on the input voltage line. The charge pump switching thresholds are hysteretic. Figure 21 shows the typical switching thresholds for the charge pump.

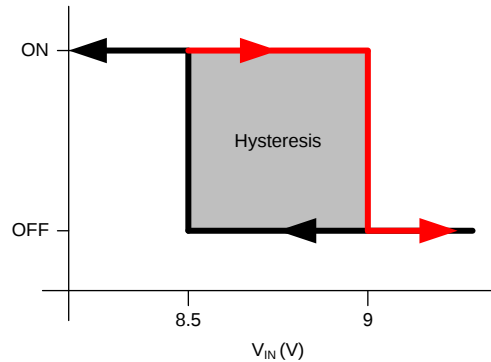


Figure 21. Charge Pump Switching Thresholds

Table 1. Typical Quiescent Current Consumption

	Charge Pump ON	Charge Pump OFF
LDO I_q	300 μ A	40 μ A

Low Voltage Tracking

At low-input voltages, the regulator drops out of regulation, and the output voltage tracks input minus a voltage based on the load current (I_{OUT}) and switch resistance (R_{SW}). This feature allows for a smaller input capacitor and can possibly eliminate the need to use a boost convertor during cold crank conditions.

Power Good Output, nRST

The nRST pin is a push-pull output. The power-on reset output is asserted low until the output voltages on LDO_OUT supplies exceeds the setting thresholds (91%) and deglitch timer has expired. Additionally, whenever EN2 pins are low or open, nRST is immediately asserted low regardless of the output voltage. If a thermal shutdown occurs due to excessive thermal conditions this pin is also asserted low.

Thermal Shutdown

The device implements an internal thermal shutdown to protect itself if the junction temperature exceeds 170°C (typ). The thermal shutdown forces the device to stop switching when the junction temperature exceeds the thermal trip threshold. Once the junction temperature decreases below 160°C (typ), the device reinitiates the power-up sequence.

Modes of Operation

The device has two hardware enable pins, and either the buck or the LDO can be turned off by pulling the enable pin low, as listed in Table 2. One unique feature of the TPS65320-Q1 device is the input auto source of the LDO. When both the buck and the LDO are enabled, the LDO gets input from the output of the buck through the VIN_LDO pin. In this mode, the buck output voltage must be higher than the LDO output voltage. When the buck is disabled and LDO is still enabled, the input of the LDO is changed automatically from VIN_LDO to VIN. This is helpful for standby operations which need a very low standby current, such as automotive infotainment, telematics, and so on. The LDO changes its input when the buck output voltage is out of regulation (V_{FB1} is less than 91% of V_{REF1}).

Table 2. Device Operation Modes

Buck EN1	LDO EN2	Description
0	0	Both buck and LDO are turned off.
0	1	Buck is disabled. LDO is enabled and LDO input is sourced from battery.
1	0	Buck is enabled and LDO is disabled.
1	1	Both buck and LDO are enabled and LDO input is sourced from buck output. Buck output voltage must be higher than LDO output voltage.

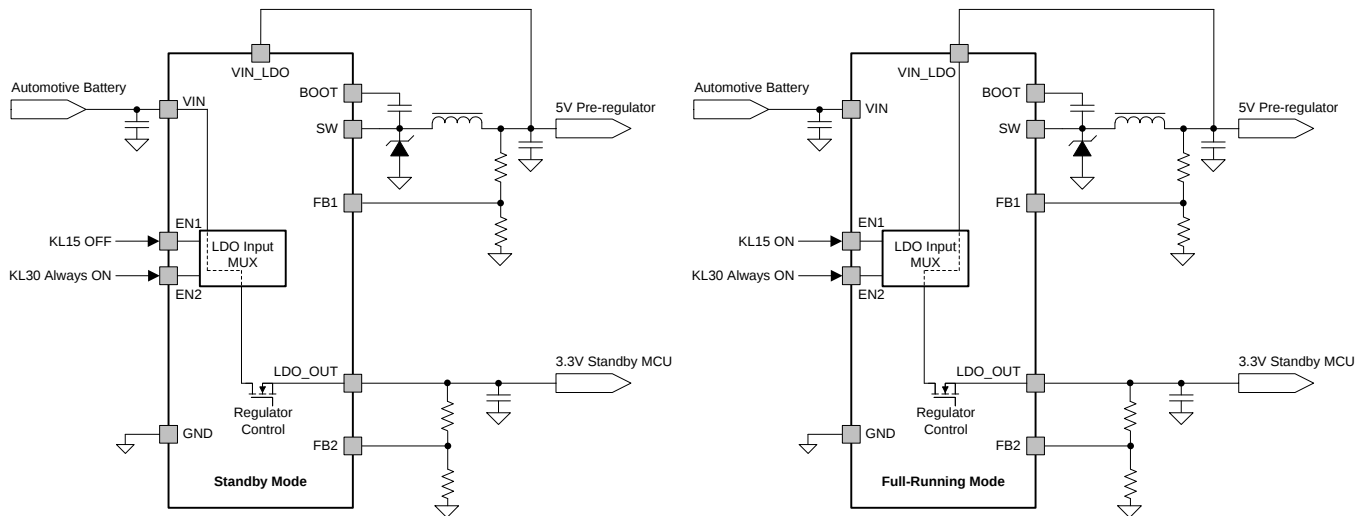


Figure 22. Example of LDO Auto Source in Standby Condition

APPLICATION INFORMATION

Design Guide – Step By Step Design Procedure

This example details the design of a high-frequency switching regulator and linear regulator using ceramic output capacitors. A few parameters must be known in order to start the design process. These parameters are typically determined at the system level. This example starts with the following known parameters (buck converter first):

Input Voltage, VIN1	9 V to 16 V, Typical 12 V
Output Voltage, VREG1 (Buck Regulator)	5 V $\pm$ 2%
Maximum Output Current I _{O_max1}	3 A
Minimum Output Current I _{O_min1}	0.01 A
Transient Response 0.01 A to 0.8 A	3%
Output Voltage Ripple	1%
Switching Frequency f _{sw}	2.2 MHz
Output Voltage, VREG2 (LDO Regulator)	3.3 V $\pm$ 2%
Overvoltage Threshold	106% of output voltage
Undervoltage Threshold	91% of output voltage

Selecting the Switching Frequency

The first step is to decide on a switching frequency for the regulator. Typically, the user chooses the highest switching frequency possible since this produces the smallest solution size. The high switching frequency allows for lower valued inductors and smaller output capacitors compared to a power supply that switches at a lower frequency. The switching frequency that can be selected is limited by the minimum on-time of the internal power switch, the input voltage, the output voltage, and the frequency shift limitation.

Minimum on-time and frequency shift protection must be considered as described in [Equation 3](#) and [Equation 4](#) to find the maximum switching frequency for the regulator, choose the lower value of the two results. Switching frequencies higher than these values result in pulse skipping or the lack of overcurrent protection during a short circuit. The typical minimum on-time, t_{onmin}, is 100 ns for the TPS65320-Q1 device. For this example, the output voltage is 5 V and the maximum input voltage is 16 V, a switching frequency of 2200 kHz is used. To determine the timing resistance for a given switching frequency, use [Equation 2](#). The switching frequency is set by the R1 resistor in [Figure 23](#). For 2.2 MHz, a 47-k Ω resistor is required.

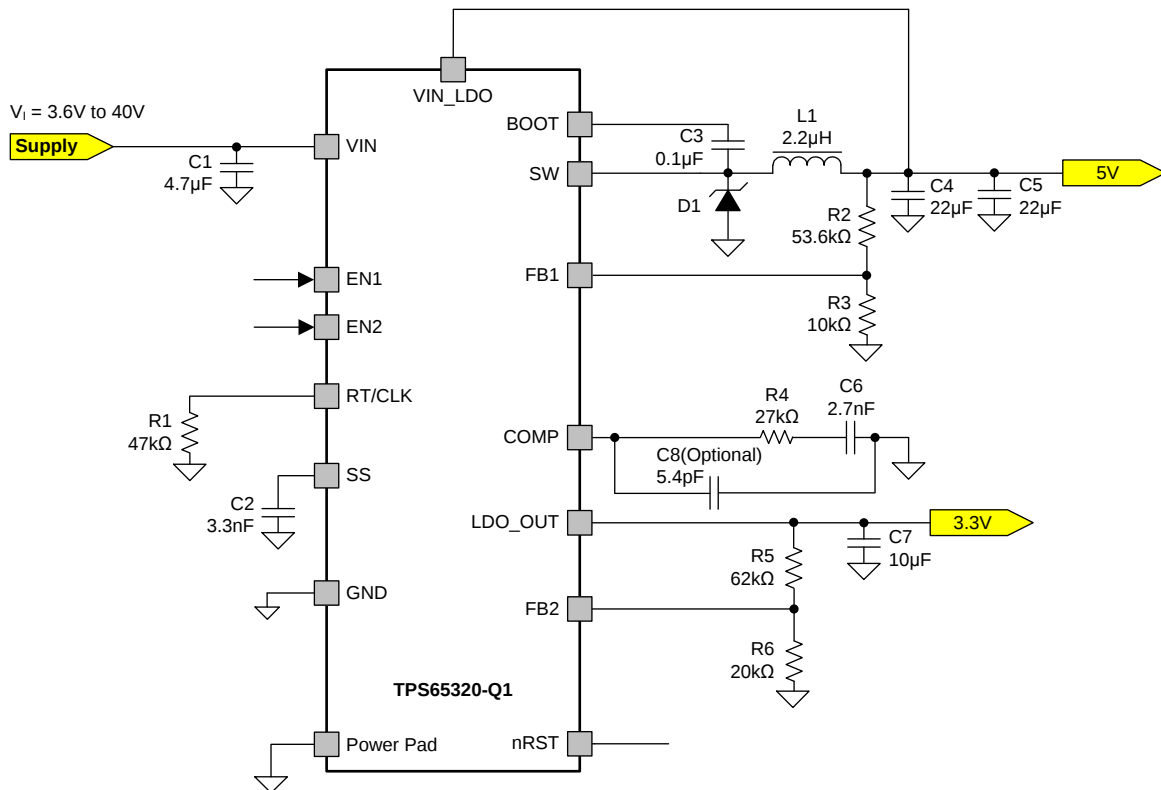


Figure 23. TPS65320-Q1 Design Example with 2.2-MHz Switching Frequency

Output Inductor Selection

To calculate the minimum value of the output inductor, use Equation 20. The inductor ripple current will be filtered by the output capacitor. Therefore, choosing high inductor ripple currents impacts the selection of the output capacitor since the output capacitor must have a ripple current rating equal to or greater than the inductor ripple current. In general, the inductor ripple value is at the discretion of the designer; however, the following guidelines may be used. K_{IND} is a coefficient that represents the amount of inductor ripple current relative to the maximum output current.

For designs using low ESR output capacitors such as ceramics, a value as high as $K_{IND} = 0.3$ may be used. When using higher ESR output capacitors, $K_{IND} = 0.2$ yields better results. In a wide input voltage regulator, it is best to choose an inductor ripple current on the larger side. This allows the inductor to still have a measurable ripple current with the input voltage at its minimum.

For this design example, use $K_{IND} = 0.3$ and the minimum inductor value is calculated to be 1.73 µH. For this design, a nearest standard value was chosen: 2.2 µH. For the output filter inductor, it is important that the RMS current and saturation current ratings not be exceeded. The RMS and peak inductor current can be found from Equation 22 and Equation 23. The inductor ripple current is 0.71 A, and the RMS current is 3.01 A.

For this design, the RMS inductor current is 3.01 A and the peak inductor current is 3.36 A. The chosen inductor is a Coilcraft MSS1038-103NLB. It has a saturation current rating of 4.52 A and an RMS current rating of 4.05 A. As the equation set demonstrates, lower ripple currents reduces the output voltage ripple of the regulator but requires a larger value of inductance. Selecting higher ripple currents increases the output voltage ripple of the regulator but allows for a lower inductance value.

$$L_{omin} = \frac{V_{in_max} - V_{out}}{I_o \times K_{IND}} \times \frac{V_{out}}{V_{in_max} \times f_{SW}} \quad (20)$$

$$I_{ripple} = \frac{V_{out} \times (V_{in_max} - V_{out})}{V_{in_max} \times L_o \times f_{SW}} \quad (21)$$

$$I_{L-RMS} = \sqrt{I_O^2 + \frac{1}{12} I_{ripple}^2} \quad (22)$$

$$I_{L-peak} = I_O + \frac{I_{ripple}}{2} \quad (23)$$

Output Capacitor

There are three primary considerations for selecting the value of the output capacitor. The output capacitor determines the modulator pole, the output voltage ripple, and how the regulator responds to a large change in load current. The output capacitance must be selected based on the most stringent of these three criteria. The desired response to a large change in the load current is the first criteria. The output capacitor must supply the load with current when the regulator cannot. This situation occurs if there are desired hold-up times for the regulator where the output capacitor must hold the output voltage above a certain level for a specified amount of time after the input power is removed. The regulator is also temporarily not able to supply sufficient output current if there is a large and fast increase in the current needs of the load, such as transitioning from no load to a full load. The regulator usually needs two or more clock cycles for the control loop to see the change in load current and output voltage, and adjust the duty cycle to react to the change. The output capacitor must be sized to supply the extra current to the load until the control loop responds to the load change. The output capacitance must be large enough to supply the difference in current for two clock cycles while only allowing a tolerable amount of droop in the output voltage. Equation 24 shows the minimum output capacitance necessary to accomplish this.

Where ΔI_{OUT} is the change in output current, f_{sw} is the switching frequency of the regulators, and ΔV_{OUT} is the allowable change in the output voltage. For this example, the transient load response is specified as a 3% change in V_{OUT} for a load step from 0.01 A to 0.8 A (full load). For this example, $\Delta I_{OUT} = 0.8 - 0.01 = 0.79$ A and $\Delta V_{OUT} = 0.03 \times 5 = 0.15$ V. Using these numbers gives a minimum capacitance of 4.7 μ F. This value does not take the ESR of the output capacitor into account in the output voltage change. For ceramic capacitors, the ESR is usually small enough to ignore in this calculation. Aluminum electrolytic and tantalum capacitors have higher ESR that should be taken into account.

The catch diode of the regulator cannot sink current, so any stored energy in the inductor will produce an output voltage overshoot when the load current rapidly decreases. The output capacitor must also be sized to absorb energy stored in the inductor when transitioning from a high load current to a lower load current. The excess energy that gets stored in the output capacitor increases the voltage on the capacitor. The capacitor must be sized to maintain the desired output voltage during these transient periods. Equation 25 is used to calculate the minimum capacitance to keep the output voltage overshoot to a desired value. Where L is the value of the inductor, I_{OH} is the output current under heavy load, I_{OL} is the output under light load, V_f is the final peak output voltage, and V_i is the initial capacitor voltage. For this example, the worst case load step is from 3 A to 0.01 A. The output voltage increases during this load transition, and the stated maximum in our specification is 3% of the output voltage. This makes $V_f = 1.03 \times 5 = 5.15$ V. V_i is the initial capacitor voltage which is the nominal output voltage of 5 V. Using these numbers in Equation 25 yields a minimum capacitance of 13 μ F.

Equation 26 calculates the minimum output capacitance needed to meet the output voltage ripple specification. Where f_{sw} is the switching frequency, V_{o_ripple} is the maximum allowable output voltage ripple, and I_{L_ripple} is the inductor ripple current. Equation 26 yields 0.8 μ F.

Equation 27 calculates the maximum ESR an output capacitor can have to meet the output voltage ripple specification. Equation 27 indicates the ESR should be less than 70 m Ω .

The most stringent criteria for the output capacitor is 13 μ F of capacitance to keep the output voltage in regulation during a load transient.

Additional capacitance deratings for aging, temperature, and DC bias should be factored in, which increases this minimum value. For this example, 2 x 22 μ F, 10-V ceramic capacitors with 3 m Ω of ESR are used. Capacitors generally have limits to the amount of ripple current they can handle without failing or producing excess heat. An output capacitor that can support the inductor ripple current must be specified. Some capacitor data sheets specify the root mean square (RMS) value of the maximum ripple current. Equation 28 can be used to calculate the RMS ripple current the output capacitor needs to support. For this application, Equation 28 yields 205 mA.

$$C_{out} > \frac{2 \times \Delta I_{out}}{f_{SW} \times \Delta V_{out}} \quad (24)$$

$$C_{out} > L_o \times \frac{(I_{oh}^2 - I_{ol}^2)}{(V_f^2 - V_i^2)} \quad (25)$$

$$C_{out} > \frac{1}{8 \times f_{SW}} \times \frac{1}{\frac{V_{o_ripple}}{I_{L_ripple}}} \quad (26)$$

$$R_{ESR} < \frac{V_{o_ripple}}{I_{L_ripple}} \quad (27)$$

$$I_{corms} < \frac{V_{out} \times (V_{in_max} - V_{out})}{\sqrt{12} \times V_{in_max} \times L_o \times f_{SW}} \quad (28)$$

Catch Diode

The TPS65320-Q1 requires an external catch diode between the SW pin and GND. The selected diode must have a reverse voltage rating equal to or greater than V_{inmax} . The peak current rating of the diode must be greater than the maximum inductor current. The diode should also have a low forward voltage. Schottky diodes are typically a good choice for the catch diode due to their low forward voltage. The lower the forward voltage of the diode, the higher the efficiency of the regulator.

Typically, the higher the voltage and current ratings the diode has, the higher the forward voltage is. Although the design example has an input voltage up to 16 V, a diode with a minimum of 40-V reverse voltage is selected to allow input voltage transients up to the rated voltage of the TPS65320-Q1 device.

For the example design, the B540C-13-F Schottky diode is selected for its lower forward voltage and it comes in a larger package size which has good thermal characteristics over small devices. The typical forward voltage of the B540C-13-F is 0.55 volts.

The diode must also be selected with an appropriate power rating. The diode conducts the output current during the off-time of the internal power switch. The off-time of the internal switch is a function of the maximum input voltage, the output voltage, and the switching frequency. The output current during the off-time is multiplied by the forward voltage of the diode which equals the conduction losses of the diode. At higher switch frequencies, the AC losses of the diode must be taken into account. The AC losses of the diode are due to the charging and discharging of the junction capacitance and reverse recovery.

Input Capacitor

The TPS65320-Q1 device requires a high quality ceramic input decoupling capacitor (type X5R or X7R) of at least 3 μ F of effective capacitance and in some applications a bulk capacitance. The effective capacitance includes any DC bias effects. The voltage rating of the input capacitor must be greater than the maximum input voltage. The capacitor must also have a ripple current rating greater than the maximum input current ripple of the TPS65320-Q1. The input ripple current can be calculated using [Equation 29](#).

The value of a ceramic capacitor varies significantly over temperature and the amount of DC bias applied to the capacitor. The capacitance variations due to temperature can be minimized by selecting a dielectric material that is stable over temperature. X5R and X7R ceramic dielectrics are usually selected for power regulator capacitors because they have a high capacitance to volume ratio and are fairly stable over temperature. The output capacitor must also be selected with the DC bias taken into account. The capacitance value of a capacitor decreases as the DC bias across a capacitor increases.

For this example design, a ceramic capacitor with at least a 40-V voltage rating is required to support the maximum input voltage. Common standard ceramic capacitor voltage ratings include 4 V, 6.3 V, 10 V, 16 V, 25 V, 50 V or 100 V, so a 50-V capacitor should be selected. For this example, 4.7- μ F, 50-V capacitors in parallel are selected. [Table 3](#) shows a selection of high voltage capacitors. The input capacitance value determines the input ripple voltage of the regulator. The input voltage ripple can be calculated using [Equation 30](#). Using the design example values, $I_{OUTmax} = 3$ A, $C_{IN} = 4.7$ μ F, $f_{sw} = 2200$ kHz, yields an input voltage ripple of 72.5 mV and an RMS input ripple current of 1.49 A.

$$I_{cirms} = I_{out} \times \sqrt{\frac{V_{out}}{V_{in\ min}} \times \frac{(V_{in\ min} - V_{out})}{V_{in\ min}}} \quad (29)$$

$$\Delta V_{in} = \frac{I_{out\ max} \times 0.25}{C_{in} \times f_{SW}} \quad (30)$$

Table 3. Capacitor Types

VENDOR	VALUE (μF)	EIA Size	VOLTAGE	DIELECTRIC	COMMENTS
Murata	1 to 2.2	1210	100 V	X7R	GRM32 series
	1 to 4.7		50 V		
	1	1206	100 V		GRM31 series
	1 to 2.2		50 V		
AVX	1 to 4.7	1210	50 V		X7R dielectric series
	1		100 V		
	1 to 4.7	1812	50 V		
	1 to 2.2		100 V		

Slow Start Capacitor

The slow start capacitor determines the minimum amount of time it takes for the output voltage to reach its nominal programmed value during power up. This is useful if a load requires a controlled voltage slew rate. This is also used if the output capacitance is large and requires large amounts of current to quickly charge the capacitor to the output voltage level. The large currents necessary to charge the capacitor may make the TPS65320-Q1 device reach the current limit or excessive current draw from the input power supply may cause the input voltage rail to sag. Limiting the output voltage slew rate solves both of these problems.

The slow start time must be long enough to allow the regulator to charge the output capacitor up to the output voltage without drawing excessive current. Equation 31 can be used to find the minimum slow start time, T_{ss} , necessary to charge the output capacitor, C_{OUT} , from 10% to 90% of the output voltage, V_{OUT} , with an average slow start current of I_{ssavg} . In the example, to charge the effective output capacitance of 44 μF up to 5 V while only allowing the average output current to be 3 A would require a 0.088 ms slow start time.

Once the slow start time is known, the slow start capacitor value can be calculated using Equation 1. For the example circuit, the slow start time is not too critical since the output capacitor value is 2 x 22 μF which does not require much current to charge to 5 V. The example circuit has the slow start time set to an arbitrary value of 1 ms which requires a 3.125-nF slow start capacitor. For this design, the next larger standard value of 3.3 nF is used.

$$T_{ss} > \frac{C_{out} \times V_{out} \times 0.8}{I_{ssavg}} \quad (31)$$

Bootstrap Capacitor Selection

A 0.1-μF ceramic capacitor must be connected between the BOOT and SW pins for proper operation. It is recommended to use a ceramic capacitor with X5R or better grade dielectric. The capacitor should have a 10 V or higher voltage rating.

Output Voltage and Feedback Resistors Selection

The voltage divider of R2 and R3 is used to set the output voltage. For the example design, 10 kΩ is selected for R3, and R2 is calculated as 53.6 kΩ. Due to current leakage of the VFB1 pin, the current flowing through the feedback network should be greater than 1 μA in order to maintain the output voltage accuracy. Choosing higher resistor values decreases the quiescent current and improves efficiency at low output currents, but may introduce noise immunity problems.

Compensation

There are several methods used to compensate DC/DC regulators. The method presented here is easy to calculate and ignores the effects of the slope compensation that is internal to the device. Since the slope compensation is ignored, the actual crossover frequency is usually lower than the crossover frequency used in the calculations. This method assumes the crossover frequency is between the modulator pole and the ESR zero, and the ESR zero is at least 10 times greater than the modulator pole.

To get started, the modulator pole, f_{P_mod} , and the ESR zero, f_{Z_mod} must be calculated using Equation 32 and Equation 33. For C_{OUT} , use a derated value of 40 μ F. Use Equation 34 and Equation 35 to estimate a starting point for the crossover frequency, f_{co} , to design the compensation. For the example design, f_{P_mod} is 2.39 kHz and f_{Z_mod} is 1.33 MHz. Equation 34 is the geometric mean of the modulator pole and the ESR zero and Equation 35 is the mean of modulator pole and the switching frequency. Equation 34 yields 56.4 kHz and Equation 35 gives 51.3 kHz. Use the lower value of Equation 34 or Equation 35 for an initial crossover frequency.

For this example, the target f_{co} is 51.3 kHz. Next, the compensation components are calculated. A resistor in series with a capacitor is used to create a compensating zero. A capacitor in parallel to these two components forms the compensating pole.

$$f_{P_mod} = \frac{1}{2\pi \times R_L \times C_{out}} = \frac{I_{max}}{2\pi \times V_{out} \times C_{out}} \quad (32)$$

$$f_{Z_mod} = \frac{1}{2\pi \times R_{ESR} \times C_{out}} \quad (33)$$

$$f_{co} = \sqrt{f_{P_mod} \times f_{Z_mod}} \quad (34)$$

$$f_{co} = \sqrt{f_{P_mod} \times \frac{f_{SW}}{2}} \quad (35)$$

The total loop gain, which consists of the product of the modulator gain, the feedback voltage-divider gain, and the error amplifier gain at f_{co} should be equal to 1. As such, Equation 36 can be used to determine the compensation resistor, R4 (see schematics in Figure 23). Assume the power stage transconductance, gm_{ps} , is 10.5 A/V. The output voltage, V_{OUT} , reference voltage, V_{REF} , and amplifier transconductance, gm_{ea} , are 5 V, 0.8 V and 310 μ A/V, respectively. R4 is calculated to be 24.74 k Ω , use 27 k Ω in this design. Use Equation 37 to set the compensation zero to the modulator pole frequency. Equation 35 yields 2468 pF for compensating capacitor C6 (see schematics in Figure 23), a 2700 pF is used for this design.

$$R4 = \left(\frac{2\pi \times f_{co} \times C_{out}}{gm_{ps}} \right) \times \left(\frac{V_{out}}{V_{ref} \times gm_{ea}} \right) \quad (36)$$

$$C6 = \frac{1}{2\pi \times R4 \times f_{P_mod}} \quad (37)$$

A compensation pole can be implemented if desired using an additional capacitor C8 in parallel with the series combination of R4 and C6. Use the larger value of Equation 38 and Equation 39 to calculate the C8, to set the compensation pole. C8 may not be used for this design example.

$$C8 = \frac{C_{out} \times R_{ESR}}{R4} \quad (38)$$

$$C8 = \frac{1}{\pi \times R4 \times f_{SW}} \quad (39)$$

LDO

Depending upon an end application, different values of external components may be used. In order to program the output voltage, feedback resistors (R5 and R6) should be carefully selected. Using smaller resistors results in higher current consumption, whereas, using very large resistors impacts the sensitivity of the regulator. It is therefore recommended to select feedback resistors such that the sum of R5 and R6 is between 20 k Ω and 200 k Ω .

If the desired regulated output voltage is 3.3 V upon selecting R6, R5 can be calculated. Knowing $V_{REF} = 0.8$ V (typical), $V_{OUT} = 3.3$ V, and selecting R6 = 20 k Ω , R5 is calculated to be 62 k Ω .

A larger output capacitor may be required during fast load steps to prevent output from temporarily dropping down. A low ESR ceramic capacitor with dielectric of type X5R or X7R is recommended. Additionally, a bypass capacitor can be connected at the output to decouple high frequency noise, per the end application.

Power Dissipation

Switch Mode Power Supply Losses:

The power dissipation losses are applicable for continuous conduction mode operation (CCM)

$$P_{CON} = I_O^2 \times R_{dsON} \times (V_O / V_I) \text{ (Conduction losses)}$$

$$P_{SW} = \frac{1}{2} \times V_I \times I_O \times (tr + tf) \times f_{SW} \text{ (Switching losses)}$$

$$P_{Gate} = V_{drive} \times Q_g \times f_{SW} \text{ (Gate drive losses)}$$

$$\text{Where typically: } Q_g = 1 \times 10^{-9} \text{ (nC)}$$

$$P_{IC} = V_I \times I_{q-normal} \text{ (Supply losses)}$$

$$P_{Total} = P_{CON} + P_{SW} + P_{Gate} + P_{LDO} + P_{IC}$$

Where:

V_O = VREG = Output voltage

V_I = Input voltage

I_O = Output current

tr = FET switching rise time ($tr_{max} = 20 \text{ ns}$)

tf = FET switching fall time ($tf_{max} = 20 \text{ ns}$)

V_{drive} = FET gate drive voltage (typically $V_{drive} = 6 \text{ V}$)

f_{SW} = Switching frequency

Linear Regulator:

$$P_{LDO} = (V_{buck} - V_{LDO}) \times I_O$$

For given operating ambient temperature T_{Amb}

$$T_J = T_{Amb} + R_{th} \times P_{Total}$$

For a given max junction temperature $T_{J-Max} = 150^\circ\text{C}$

$$T_{Amb-Max} = T_{J-Max} - R_{th} \times P_{Total}$$

Where:

P_{Total} = Total power dissipation (Watts)

T_{Amb} = Ambient Temperature in $^\circ\text{C}$

T_J = Junction Temperature in $^\circ\text{C}$

$T_{Amb-Max}$ = Maximum Ambient Temperature in $^\circ\text{C}$

T_{J-Max} = Maximum junction temperature in $^\circ\text{C}$

R_{th} = Thermal resistance of package in $(^\circ\text{C}/\text{W})$

Other factors NOT included in the information above which affect the overall efficiency and power losses are:

- Inductor AC and DC losses
- Trace resistance and losses associated with the copper trace routing connection
- Schottky diode

PCB Layout

The following guidelines are recommended for PCB layout of the TPS65320-Q1 device.

Inductor L

Use a low EMI inductor with a ferrite type shielded core. Other types of inductors may be used, however they must have low EMI characteristics and be located away from the low power traces and components in the circuit.

Input Filter Capacitors C_I

Input ceramic filter capacitors should be located in the close proximity of the VIN terminal. Surface mount capacitors are recommended to minimize lead length and reduce noise coupling.

Feedback

Route the feedback trace such that there is minimum interaction with any noise sources associated with the switching components. The recommended practice is to ensure the inductor is placed away from the feedback trace to prevent EMI noise source.

Traces and Ground Plane

All power (high current) traces should be as thick and short as possible. The inductor and output capacitors should be as close to each other as possible. This reduces EMI radiated by the power traces due to high switching currents. In a two-sided PCB it is recommended to have ground planes on both sides of the PCB to help reduce noise and ground loop errors. The ground connection for the input and output capacitors and IC ground should be connected to this ground plane. In a multi-layer PCB, the ground plane is used to separate the power plane (where high switching currents and components are placed) from the signal plane (where the feedback trace and components are) for improved performance. Also, arrange the components such that the switching current loops curl in the same direction. Place the high current components such that during conduction the current path is in the same direction. This prevents magnetic field reversal caused by the traces between the two half cycles, and helps reduce radiated EMI.

Other Application Example

For a 300-kHz operation, a 10-μH inductor and a 47-μF × 2 output capacitor are chosen.

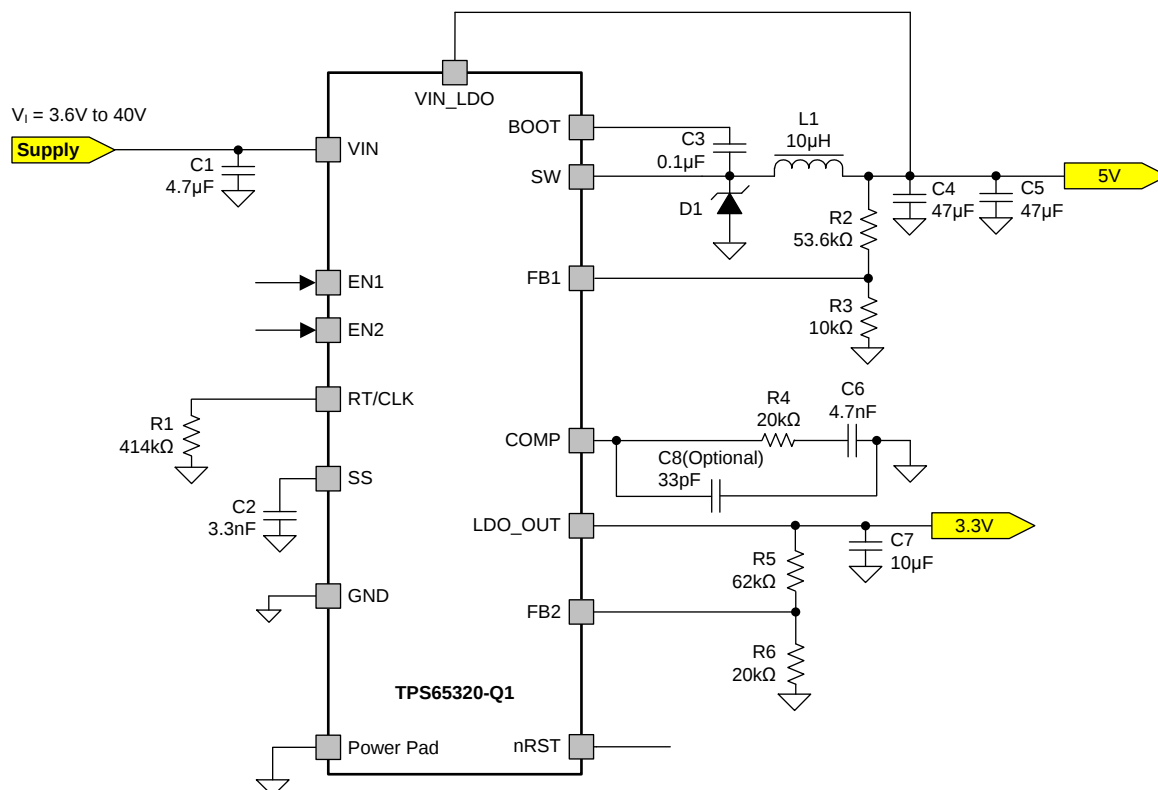


Figure 24. TPS65320-Q1 Design Example with 300-kHz Switching Frequency

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish	MSL Peak Temp (3)	Samples (Requires Login)
TPS65320QPWPRQ1	ACTIVE	HTSSOP	PWP	14	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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TAPE AND REEL INFORMATION



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TPS65320QPWPRQ1	HTSSOP	PWP	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1

TAPE AND REEL BOX DIMENSIONS

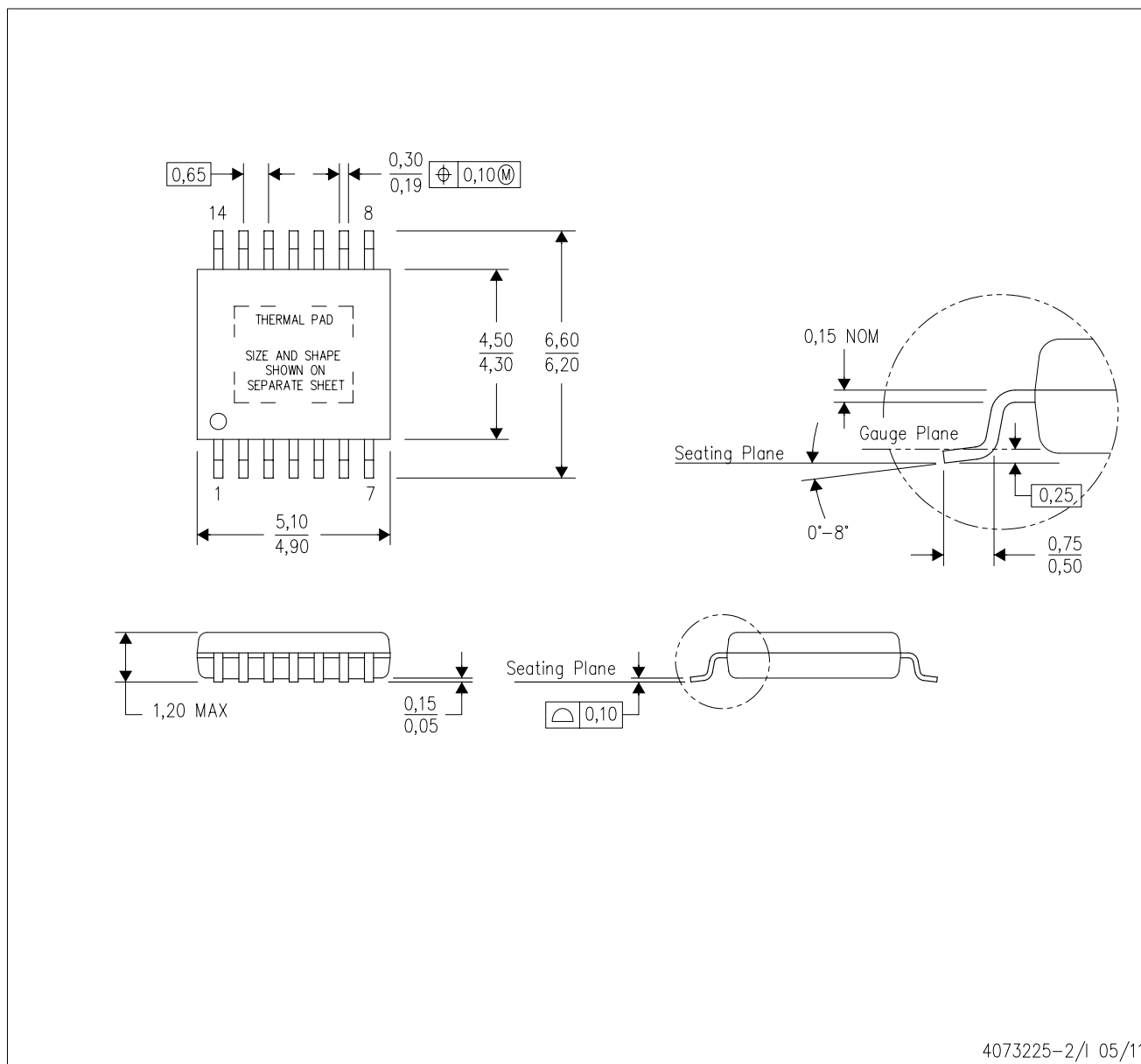


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TPS65320QPWPRQ1	HTSSOP	PWP	14	2000	367.0	367.0	35.0

PWP (R-PDSO-G14)

PowerPAD™ PLASTIC SMALL OUTLINE



- NOTES:
- A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. Body dimensions do not include mold flash or protrusions. Mold flash and protrusion shall not exceed 0.15 per side.
 - D. This package is designed to be soldered to a thermal pad on the board. Refer to Technical Brief, PowerPad Thermally Enhanced Package, Texas Instruments Literature No. SLMA002 for information regarding recommended board layout. This document is available at www.ti.com <<http://www.ti.com>>.
 - E. See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.
 - E. Falls within JEDEC MO-153

PowerPAD is a trademark of Texas Instruments.

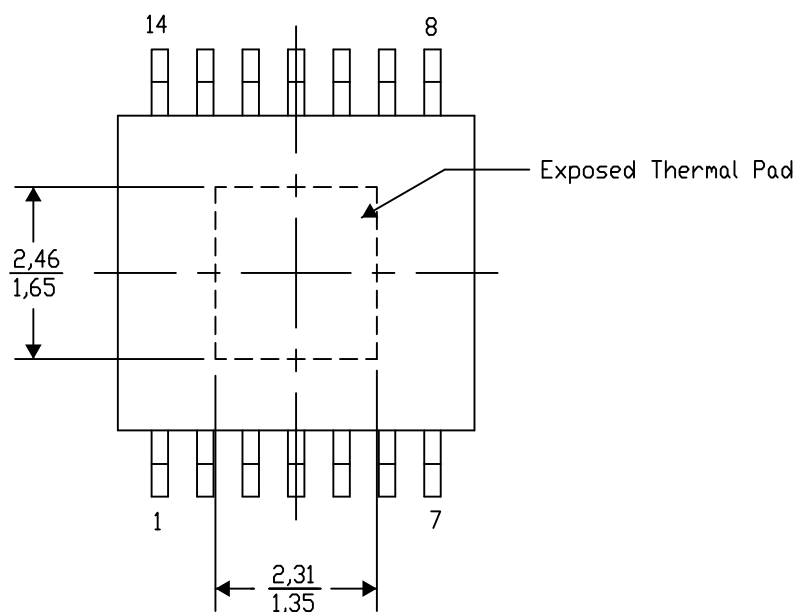
PWP (R-PDSO-G14) PowerPAD™ SMALL PLASTIC OUTLINE

THERMAL INFORMATION

This PowerPAD™ package incorporates an exposed thermal pad that is designed to be attached to a printed circuit board (PCB). The thermal pad must be soldered directly to the PCB. After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For additional information on the PowerPAD package and how to take advantage of its heat dissipating abilities, refer to Technical Brief, PowerPAD Thermally Enhanced Package, Texas Instruments Literature No. SLMA002 and Application Brief, PowerPAD Made Easy, Texas Instruments Literature No. SLMA004. Both documents are available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



Top View

Exposed Thermal Pad Dimensions

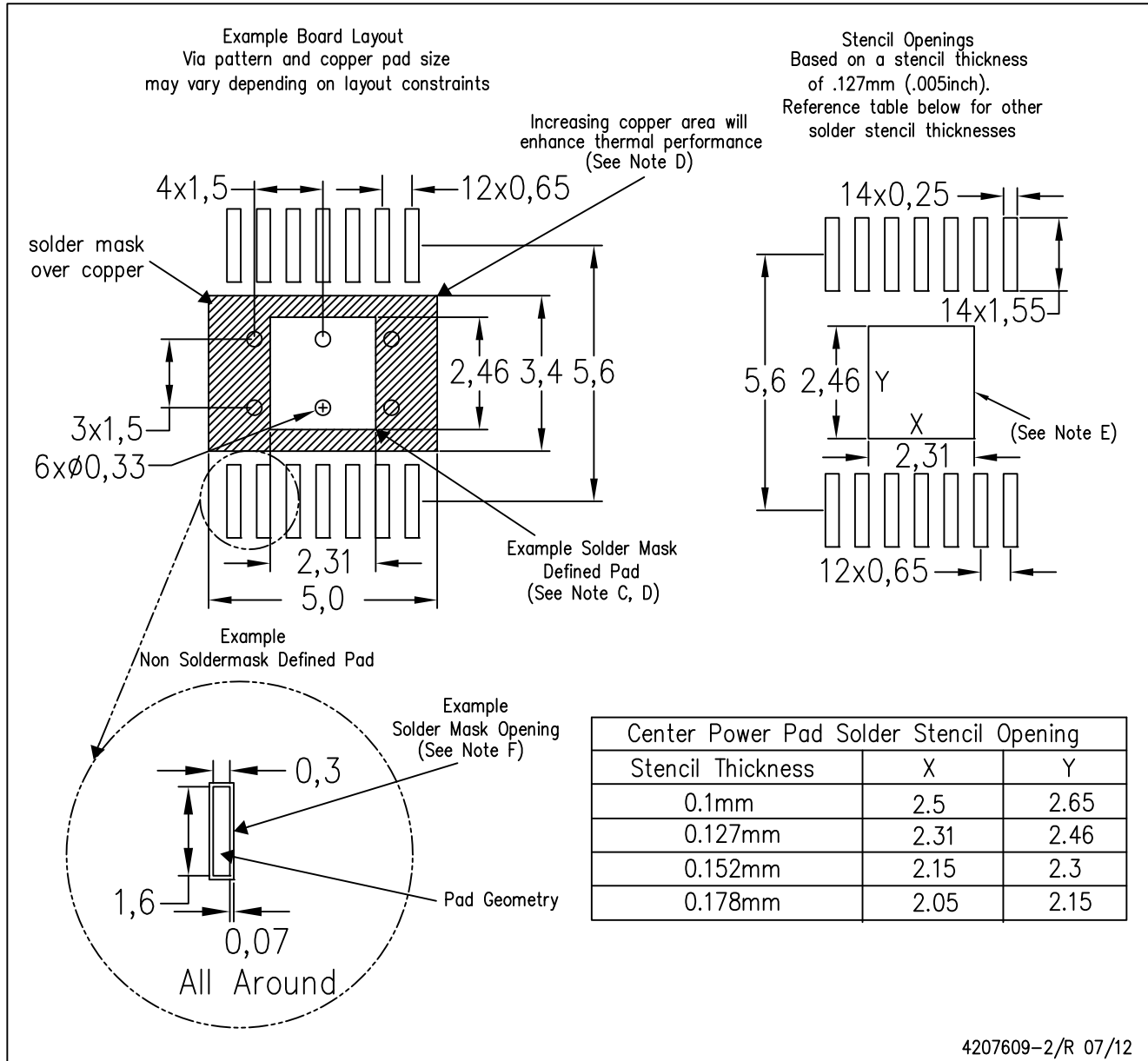
4206332-2/AC 07/12

NOTE: A. All linear dimensions are in millimeters

PowerPAD is a trademark of Texas Instruments

PWP (R-PDSO-G14)

PowerPAD™ PLASTIC SMALL OUTLINE



- NOTES:
- All linear dimensions are in millimeters.
 - This drawing is subject to change without notice.
 - Customers should place a note on the circuit board fabrication drawing not to alter the center solder mask defined pad.
 - This package is designed to be soldered to a thermal pad on the board. Refer to Technical Brief, PowerPad Thermally Enhanced Package, Texas Instruments Literature No. SLMA002, SLMA004, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com <<http://www.ti.com>>. Publication IPC-7351 is recommended for alternate designs.
 - Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC-7525 for other stencil recommendations.
 - Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

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